

<b>FORM PTO-1449 (MODIFIED)</b>  <b>LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT</b>	<b>ATTORNEY DOCKET NO.</b>  SP03-174	<b>SERIAL NO.</b>
	<b>APPLICANT</b> Benjamin L. Hall, et al.	
	<b>FILING DATE</b>	<b>GROUP:</b>

REFERENCE DESIGNATION		U.S. PATENT and PUBLICATION DOCUMENTS					
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
RAR	AA	5,703,892	12/30/97	Claisse, et al	372	32	
RAR	AB	5,767,507	6/16/98	Unlu, et al	250	225	
RAR	AC	5,949,534	9/7/99	Guttman, et al	356	121	
RAR	AD	6,175,446	1/16/01	Alphonse	359	344	
RAR	AE	6,330,378	12/11/01	Forrest, et al	385	14	
RAR	AF	6,483,580	11/19/02	Xu, et al	356	300	
RAR	AG	6,501,260	12/31/02	Hu, et al	324	158.1	
RAR	AH	2003/0095264	5/22/03	Ruchet	356	491	
RAR	AI						
RAR	AJ						
RAR	AK						

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
RAR	AL	WO 01/36931	5/25/01	PCT			
	AM						
	AN						
	AO						
	AP						
	AQ						

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)		
RAR	AR	"Theory of Spontaneous Emission Noise in Open Resonators and its Application to Lasers and Optical Amplifiers" C. H. Henry J. of Lightwave Technology, Vol. Lt-4, No. 3, March 1986
RAR	AS	"A Comparison of Far-Field Methods for Determining Mode Field Diameter of Single-Mode Fibers Using Both Gaussian and Petermann Definitions" T. J. Drapela, et al J. of Lightwave Technology, Vol. 7, No. 8, August 1989
	AT	
	AU	
	AV	
	AW	

EXAMINER: /Richard Rosenberger/ DATE CONSIDERED: 05/11/2006

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



FORM PTO-1449 (MODIFIED)

LIST OF PATENTS AND  
PUBLICATIONS  
FOR APPLICANTS INFORMATION  
DISCLOSURE STATEMENT

ATTORNEY DOCKET NO.

SP03-174

SERIAL NO.

10/733,903

APPLICANT Benjamin L. Hall, et al.

FILING DATE December 11,  
2003

GROUP: 2877

REFERENCE DESIGNATION		U.S. PATENT DOCUMENTS					
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
RAR	AA	2002/0114067	8/22/2002	Walter, et al	359	344	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
RAR	AL	EP1220394A2	3/7/2002	Europe			
RAR	AM	02-240990	25/9/1990	Japan			x
	AN						
	AO						
	AP						
	AQ						

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)	
AR	
AS	
AT	
AU	
AV	
AW	

EXAMINER: /Richard Rosenberger/

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